

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

May 2, 2002

ATTY DOCKET NO.
00862.022511APPLICATION NO.
10/066,620APPLICANT
Atsushi TANAKAFILING DATE
February 6, 2002RECEIVED
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2671

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U.S. PATENT DOCUMENTS

*EXAMINER INITIALS <i>OIP VS</i>	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MAY 02 2002 <i>PTM - TRADEMARK OFFICE</i>	4,613,964	09/23/1986	Ichikawa, et al.	369	45	
	4,886,943	12/12/1989	Suzuki, et al.	178	18	
	4,887,245	12/12/1989	Mori, et al.	367	129	
	4,897,510	01/30/1990	Tanaka, et al.	178	18	
	4,910,363	03/20/1990	Kobayashi, et al.	178	18	
	4,931,965	06/05/1990	Kaneko, et al.	364	560	
	4,980,518	12/25/1990	Kobayashi, et al.	178	18	
	5,017,913	05/21/1991	Kaneko, et al.	340	712	
	5,070,325	12/03/1991	Tanaka, et al.	340	706	
	5,097,102	03/17/1992	Yoshimura, et al.	178	18	
<i>VS</i>	5,142,106	08/25/1992	Yoshimura, et al.	178	18	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO OR ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

V. Shan Lan

DATE CONSIDERED

11/24/03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.
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Sheet 1 of 3

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL VS	DOCUMENT NUMBER	DATE	NAME	Technology Center 2600	CLASS	SUBCLASS	FILING DATE
MAY 02 2002 PATENT TRADE MARK OFFICE	5,210,785	05/11/1993	Sato, et al.	379	58		
	5,231,394	07/27/1993	Sato	341	50		
	5,239,138	08/24/1993	Kobayashi, et al.	178	18		
	5,500,492	03/19/1996	Kobayashi, et al.	178	18		
	5,517,553	05/14/1996	Sato	379	59		
	5,539,678	07/23/1996	Tanaka, et al.	364	561		
	5,565,893	10/15/1996	Sato, et al.	345	177		
	5,621,300	04/15/1997	Sato, et al.	320	5		
	5,714,698	02/03/1998	Tokioka, et al.	73	865.4		
	5,736,979	04/07/1998	Kobayashi, et al.	345	177		
	5,751,133	05/12/1998	Sato, et al.	320	13		
	5,805,147	09/08/1998	Tokioka, et al.	345	173		
	5,818,429	10/06/1998	Tanaka, et al.	345	173		
VS	5,831,603	11/03/1998	Yoshimura, et al.	345	177		

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Sheet 2 of 3

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